SILICENE: The silicon counterpart of Graphene







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"History does not repeat itself, but it does rhyme"

Mark Twain













Silicene Synthesis ? YES Electronic properties ? Introduction



Introduction

Electronic configuration



[He] $2s^2 2p^2$

$$Ec_{2s} = 19.4 \text{ eV}$$

 $Ec_{2p} = 10.7 \text{ eV}$

Silicon

[Ne]
$$3\underline{s}^2 3\underline{p}^2 = 5.0eV$$

Esi_{3p} = 7.8eV



 $Ec_{2s} - Ec_{2p} = 8.7eV$ > $Esi_{2s} - Esi_{2p} = 7.2 eV$ Diamond Silicon

sp3 Tetrahedral



Graphite



Acetylene

Linear



.....

Trigonal planar



Introduction

Electronic configuration



Germanium

Trigonal planar





[Ar] $4\underline{s}^2 4\underline{p}^2 = \frac{E_{Ge_{4s}}}{E_{Ge_{4s}}} = 7.5 \text{ eV}$



Tetrahedral

-C.....

Trigonal planar

 $E_{C_{2s}} - E_{C_{2p}} = 8.7 eV$ > $E_{Ge_{4s}} - E_{Ge_{4p}} = 8.1 eV$ Diamond Germanium (Diamond) Graphite Tetrahedral _ Germanene???



Acetylene





Silicene across the world

Worldewide contributions





Theoretical study

Stability and electronic properties :

(TB) G. Guzmán-Verri, et al, Phys. Rev. B 76, 075131 (2007) (DFT) S. Lebègue et al, Phys. Rev. B 79 115409 (2009) (DFT) Cahangirov et al, Phys. Rev. Let. 102, 236804, (2009)









- Silicene has intrinsic stability and an electronic structure similar to the one of graphene.



S. Lebègue et al, Phys. Rev. B 79 115409 (2009)



Si/Ag(110) at RT

Ordered Si Nanoribbons with the same width (0.16 nm)



22x22 nm²

Léandri et al. Surf. Sci., 574, L9 (2005)



Si/Ag(110)



B. Aufray et al. Appl. Phys. Lett. 96, 183102 (2010) A. Kara et al. Surf. Sci. Reports, 67, 1–18 (2012)





STM

Ab initio calculations



A. Kara et al. J. Phys. Condens. Matter 22, 045004 (2010)



Deposition at 220°C: 1 ML of Si/Ag(110)

STM



2x5 superstructure

 $15x15 \text{ nm}^2$, V = -0.9 V ; I = 0.5 nA



Deposition at 220°C: 1 ML of Si/Ag(110)

STM



 $8x8 \text{ nm}^2$, V = -1.6 V ; I = 3.2 nA

Self-assembled Si NRs

M. R. TCHALALA et al. (accepted)





Chemical reactivity toward O₂





Hollow

/[-110]





27.3 nm x 27.3 nm

STM

Oxidation starts from the NRs extremities

De. Padova et al. Nano Letters 8 (8), 2299-2304 (2008)



Core Level Photo-Electron Spectroscopy (Synchrotron radiation)

θ ≈ 0,5 ML



C. Leandri et al. Surf. Sci., 574, (2005) L9 De Padova et al., Nano Letters 8 (2008) 271 De. Padova et al. Appl. Phys. letters, 96, 261905 (2010)



Core Level Photo-Electron Spectroscopy (Synchrotron radiation) PES



Silicene NRs are not reactive to molecular Oxygen





Si/Ag(111)

(2√3 x 2√3)R30°



22x22 nm² , V=0,1 V , I=1,9 nA





B. Lalmi etal, APL, 97, 223109 (2010)



Si/Ag(111)





STM



Si/Ag(111) **4x4**



420 K



480 K



single layer of silicene



(√3×√3)R30°

Lan Chen et al, Phys. Rev. Lett., 110, 085504 (2013) Baojie Feng et al, Nano Lett., 12 (7), 3507 (2012)



H. Enriquez et al. Journal. of Phys. Condens. Matter, 24, 314211 (2012)



Si/Ag(111) : STM and nc-AFM



Z. Majzik J. Phys.: Condens. Matter, 25, 225301 (2013)



Si/ZrB2 (0001)



FIG. 1 (color). STM images of the (2×2) -reconstructed ZrB₂(0001) surface with different length scales: (a) 20 nm× 9.5 nm, I = 55 pA, $V_s = 700$ mV, (b) 4.2 nm × 2 nm, I = 600 pA, $V_s = 100$ mV. The white lines emphasize the direction of offsets between successive domains. The (2×2) UC and the honeycomb mesh are emphasized by green and blue solid lines, respectively.



 $15x15 \text{ nm}^2$, V = -0.9 V ; I = 0.5 nA Silicene on Ag(110)



Si/Ir(111)





Figure 3. (a) Zoomed-in STM image of the silicon layer. Besides the brightest protrusions, two other regions showing different contrast are indicated by the upward and downward triangles. The honeycomb feature is indicated by the black hexagon. (b) Simulated STM image, showing features identical with the experimental results in the same triangles and hexagons. (c) Top view of the relaxed atomic model of the $(\sqrt{3}\times\sqrt{3})$ silicene/ $(\sqrt{7}\times\sqrt{7})$ Ir(111) configuration. (d) Perspective view of the relaxed model in c, showing an undulated silicene on Ir(111) surface.

Lei Meng et al. Nano Lett., 2013, 13 (2), pp 685–690



Si/Au(110)





M. R. TCHALALA et al. APL, 102, 083107 (2013)

SINRs on Au(110)-2x



S1 ----> Silicon within the NRs

S2 —> Silicon at the NRS edges

Two well defined components Asymmetry : 0.09 Two Si environments

M. R. TCHALALA et al. APL, 102, 083107 (2013)



Electronic properties

Dirac cone or no Dirac cone





Si/Ag(111)

Electronic properties (HRPES)

(4x4) superstructure



FIG. 2 (color). (a) Filled-states STM image of the 2D Si layer on Ag(111)-(1×1) ($U_{\text{bias}} = -1.3 \text{ V}$, I = 0.35 nA). Clearly visible is the honeycomblike structure. (b) Line profile along be dashed white line indicated in (a). The dark centers in the ST I micrograph are separated by 1.14 nm, corresponding to 4 darks the Ag(111) lattice constant, in agreement with the (4×4) symmetry. (c) High-resolution STM topograph ($3 \times 3 \text{ nm} U_{\text{bias}} = -1.3 \text{ V}$, I = 0.35 nA) of the Si adlayer.

Cone



FIG. 3 (color). (a) ARPES intensity map for the claim Ag surface (left) and after formation of the 2D Si adlayer (right), taken along the Ag $\overline{\Gamma}$ - \overline{K} direction through the silicene $\overline{K}(h\nu)$ (b) Brillouin-zone (BZ) scheme of the 2D Si layer with respect to the Ag(111)-(1 × 1) surface. The red arrow indicates the ARPES measurement direction.

Linear dispesion

P. Vogt et al. PRL 108, 155501 (2012)

Silicene sheet:

Si/Ag(111)

Electronic properties (STS)



Linear dispesion

FIG. 4 (color online). (a) dI/dV curves taken at 77 K. The position of the DP is labeled. (b) The STM image (40 nm × 40 nm) of the 1 ML silicene surface containing an island of second layer taken at tip bias -1.0 V. (c), (d), and (e) dI/dV maps of the same area as (b) taken at tip bias -1.0, -0.8, and -0.5 V, respectively. (f) Energy dispersion as a function of κ for silicene determined from the wavelength of QPI patterns. The inset shows a schematic drawing of the overall band structure, with the relative location of the DP, E_F , and our data points [red (thick gray) line].

-0.5 V High h at 77 K. STM image ontaining an (c), (d), and o bias -1.0, on as a funcngth of QPI overall band and our data Lan Chen et al. PRL 109, 056804 (2012)





Si/Ag(111)

PHYSICAL REVIEW B 87, 245430 (2013)

Absence of a Dirac cone in silicene on Ag(111): First-principles density functional calculations with a modified effective band structure technique

Yun-Peng Wang and Hai-Ping Cheng*

Quantum Theory Project and Department of Physics, University of Florida, Gainesville, Florida 32611, USA (Received 22 February 2013; revised manuscript received 3 April 2013; published 24 June 2013)

We investigate the currently debated issue of the existence of the Dirac cone in silicene on an Ag(111) surface, using first-principles calculations based on density functional theory to obtain the band structure. By unfolding the band structure in the Brillouin zone of a supercell to that of a primitive cell, followed by projecting onto Ag and silicene subsystems, we demonstrate that the Dirac cone in silicene on Ag(111) is destroyed. Our results clearly indicate that the linear dispersions observed in both angular-resolved photoemission spectroscopy [P. Vogt *et al.* Phys. Rev. Lett. **108**, 155501 (2012)] and scanning tunneling spectroscopy [L. Chen *et al.*, Phys. Rev. Lett. **163**, 0 6804 (2012)] come from the Ag substrate and not from silicene.

Y. Peng et al. Phys. Rev. B. 87 245430 (2013)



Si/Ag(111)



FIG. 2. (Colr. online) Si- and Ag-projected effective band structure (EBS) of the silicene-Ag system. (a) Si-projected effective band structures, with kand-structure of standalone low-buckled silicene plotted as blue dashed lines. Note that the band structure of low-buckled silicene was shifted Q wavered by 1.1 eV. (b) Ag-projected effective band structures with experimental observed linear dispersions (red circles: measurements from Ref. 7), blue squares: measurements from Ref. 8).

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Y. Peng et al. Phys. Rev. B. 87 245430 (2013)



Chemical Synthesis



Future challenges



H. Nakano et al. Angew.Chzem. 2006, 118 6451-6454



SILICON SHEETS BY REDOX ASSISTED CHEMICAL EXFOLIATION



TEM

Silicon with graphitic structure

M. R. TCHALALA J. Phys.: Condens. Matter, 25, 442001 (2013)



Silicene growth and transferability

- How to grow silicene on large scale-area on insulators ?
- Can we control the interaction of silicene with its supporting substrate for transferablity ?
- Synthesis by chemical methods ?





- Experimental evidence of Silicene on different substrates (Nano-ribbons and sheet)

- Electronic properties of silicene still under debate

Co-workers

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